



M. Flom Associates, Inc. - Global Compliance Center

3356 North San Marcos Place, Suite 107, Chandler, Arizona 85225-7176

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Date: September 22, 2000

Federal Communications Commission

Via: Electronic Filing VIA T.C.B.

Attention: Authorization & Evaluation Division

Applicant: Kenwood Communications Corporation

Equipment: TK-860HG-2 and TK-862HG-2

FCC ID: ALH29383220

FCC Rules: 90

Gentlemen:

On behalf of the Applicant, enclosed please find Application Form 731, Engineering Test Report and all pertinent documentation, the whole for approval of the referenced equipment as shown.

Filing fees are attached.

We trust the same is in order. Should you need any further information, kindly contact the writer who is authorized to act as agent.

Sincerely yours,

A handwritten signature in black ink, reading 'M. Flom P. Eng.', with a horizontal line underneath.

Morton Flom, P. Eng.

enclosure(s)
cc: Applicant
MF/cvr

LIST OF EXHIBITS
(FCC **CERTIFICATION** ~~(TRANSMITTERS)~~ - REVISED 9/28/98)

APPLICANT: Kenwood Communications Corporation

FCC ID: ALH29383220

BY APPLICANT:

1. LETTER OF AUTHORIZATION
2. IDENTIFICATION DRAWINGS, 2.1033(c)(11)
 - ___ LABEL
 - ___ LOCATION OF LABEL
 - ___ COMPLIANCE STATEMENT
 - ___ LOCATION OF COMPLIANCE STATEMENT
3. PHOTOGRAPHS, 2.1033(c)(12)
4. DOCUMENTATION: 2.1033(c)
 - (3) USER MANUAL
 - (9) TUNE UP INFO
 - (10) SCHEMATIC DIAGRAM
 - (10) CIRCUIT DESCRIPTION
 - BLOCK DIAGRAM
 - PARTS LIST
 - ACTIVE DEVICES
5. PART 90.203(e) & (g) ATTESTATION

BY M.F.A. INC.

- A. TESTIMONIAL & STATEMENT OF CERTIFICATION
- B. STATEMENT OF QUALIFICATIONS



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Sub-part
2.1033(c):

EQUIPMENT IDENTIFICATION

FCC ID: ALH29383220

NAMEPLATE DRAWING

ATTACHED, EXHIBIT 1.

LOCATION

AS PER LABEL DRAWING(S)

DATE OF REPORT

September 22, 2000

SUPERVISED BY:

A handwritten signature in black ink, reading 'M. Flom P. Eng.' with a stylized, cursive-like script.

Morton Flom, P. Eng.

THE APPLICANT HAS BEEN CAUTIONED AS TO THE FOLLOWING:

15.21 INFORMATION TO USER.

The users manual or instruction manual for an intentional radiator shall caution the user that changes or modifications not expressly approved by the party responsible for compliance could void the user's authority to operate the equipment.

15.27(a) SPECIAL ACCESSORIES.

Equipment marketed to a consumer must be capable of complying with the necessary regulations in the configuration in which the equipment is marketed. Where special accessories, such as shielded cables and/or special connectors are required to enable an unintentional or intentional radiator to comply with the emission limits in this part, the equipment must be marketed with, i.e. shipped and sold with, those special accessories. However, in lieu of shipping or packaging the special accessories with the unintentional or intentional radiator, the responsible party may employ other methods of ensuring that the special accessories are provided to the consumer, without additional charge.

Information detailing any alternative method used to supply the special accessories for a grant of equipment authorization or retained in the verification records, as appropriate. The party responsible for the equipment, as detailed in § 2.909 of this chapter, shall ensure that these special accessories are provided with the equipment. The instruction manual for such devices shall include appropriate instructions on the first page of text concerned with the installation of the device that these special accessories must be used with the device. It is the responsibility of the user to use the needed special accessories supplied with the equipment.

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Required information per ISO/IEC Guide 25-1990, paragraph 13.2:

a)

TEST REPORT

b) Laboratory: M. Flom Associates, Inc.
(FCC: 31040/SIT) 3356 N. San Marcos Place, Suite 107
(Canada: IC 2044) Chandler, AZ 85224

c) Report Number: d0090050

d) Client: Kenwood Communications Corporation
P.O. Box 22745
Long Beach, CA 90801-5745

e) Identification: TK-860HG-2 and TK-862HG-2
FCC ID: ALH29383220
Description: UHF FM Transceiver

f) EUT Condition: Not required unless specified in individual tests.

g) Report Date: September 22, 2000
EUT Received: September 13, 2000

h, j, k): As indicated in individual tests.

i) Sampling method: No sampling procedure used.

l) Uncertainty: In accordance with MFA internal quality manual.

m) Supervised by:



Morton Flom, P. Eng.

n) Results: The results presented in this report relate only to the item tested.

o) Reproduction: This report must not be reproduced, except in full, without written permission from this laboratory.

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LIST OF GENERAL INFORMATION REQUIRED FOR CERTIFICATION

IN ACCORDANCE WITH FCC RULES AND REGULATIONS,
VOLUME II, PART 2 AND TO

90

Sub-part 2.1033

(c)(1): NAME AND ADDRESS OF APPLICANT:

Kenwood Communications Corporation
2201 E. Dominguez St
P.O. Box 22745
Long Beach, CA 90801-5745

MANUFACTURER:

Kenwood Electronics Technologies PTE Ltd.
1 Ang Mo Kio Street 63
Singapore 569110

(c)(2): FCC ID: ALH29383220

MODEL NO: TK-860HG-2 and TK-862HG-2

(c)(3): INSTRUCTION MANUAL(S):

PLEASE SEE ATTACHED EXHIBITS

(c)(4): TYPE OF EMISSION: 16K0F3E, 11K0F3E, 19K2F1D

(c)(5): FREQUENCY RANGE, MHz: 485 to 512

(c)(6): POWER RATING, Watts: 10 to 40
___ Switchable ___ x Variable ___ N/A

(c)(7): MAXIMUM POWER RATING, Watts: 500

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M. Flom Associates, Inc. is accredited by the American Association for Laboratory Association (A2LA) as shown in the scope below.



**THE AMERICAN
ASSOCIATION
FOR LABORATORY
ACCREDITATION**

ACCREDITED LABORATORY

A2LA has accredited

M. FLOM ASSOCIATES, INC.
Chandler, AZ

for technical competence in the field of

Electrical (EMC) Testing

The accreditation covers the specific tests and types of tests listed on the agreed scope of accreditation. This laboratory meets the requirements of ISO/IEC Guide 25-1990 "General Requirements for the Competence of Calibration and Testing Laboratories" (equivalent to relevant requirements of the ISO 9000 series of standards) and any additional program requirements in the identified field of testing.

Presented this 24th day of November, 1998.



Peter Nijzen
President
For the Accreditation Council
Certificate Number 1008.01
Valid to December 31, 2000

For tests or types of tests to which this accreditation applies, please refer to the laboratory's Electrical (EMC) Scope of Accreditation



American Association for Laboratory Accreditation

SCOPE OF ACCREDITATION TO ISO/IEC GUIDE 25-1990 AND EN 45001

M. FLOM ASSOCIATES, INC.
Electronic Testing Laboratory
3356 North San Marcos Place, Suite 107
Chandler, AZ 85225
Morton Flom Phone: 480 926 3100

ELECTRICAL (EMC)

Valid to: December 31, 2000 Certificate Number: 1008-01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following electromagnetic compatibility tests:

Tests	Standard(s)
RF Emissions	FCC Part 15 (Subparts B and C) using ANSI C63.4-1992; CISPR 11; CISPR 13; CISPR 14; CISPR 22; EN 55011; EN 55013; EN 55014; EN 55022; EN 50081-1; EN 50081-2; FCC Part 18; ICES-003; AS/NZS 1044; AS/NZS 1053; AS/NZS 3548; AS/NZS 4251.1; CNS 13438
RF Immunity	EN 50082-1; EN 50082-2; AS/NZS 4251.1
Radiated Susceptibility	EN 61000-4-3; ENV 50140; ENV 50204; IEC 1000-4-3; IEC 801-3
ESD	EN 61000-4-2; IEC 1000-4-2; IEC 801-2
EFT	EN 61000-4-4; IEC 1000-4-4; IEC 801-4
Surge	EN 61000-4-5; ENV 50142; IEC 1000-4-5; IEC 801-5
47 CFR (FCC)	2, 21, 22, 23, 24, 74, 80, 87, 90, 95, 97

Revised 2/2/2000

Peter Nijzen

5301 Buckeystown Pike, Suite 350 • Frederick, MD 21704-8370 • Phone: 301 644 3248 • Fax: 301 662 2974

"This laboratory is accredited by the American Association for Laboratory Accreditation (A2LA) and the results shown in this report have been determined in accordance with the laboratory's terms of accreditation unless stated otherwise in the report."

Should this report contain any data for tests for which we are not accredited, or which have been undertaken by a subcontractor that is not A2LA accredited, such data would not covered by this laboratory's A2LA accreditation.

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Subpart 2.1033 (continued)

(c)(8): VOLTAGES & CURRENTS IN ALL ELEMENTS IN FINAL R. F. STAGE,
INCLUDING FINAL TRANSISTOR OR SOLID STATE DEVICE:

COLLECTOR CURRENT, A = per manual
COLLECTOR VOLTAGE, Vdc = per manual
SUPPLY VOLTAGE, Vdc = 13.6

(c)(9): TUNE-UP PROCEDURE:

PLEASE SEE ATTACHED EXHIBITS

(c)(10): CIRCUIT DIAGRAM/CIRCUIT DESCRIPTION:

Including description of circuitry & devices provided for
determining and stabilizing frequency, for suppression of
spurious radiation, for limiting modulation and limiting
power.

PLEASE SEE ATTACHED EXHIBITS

(c)(11): LABEL INFORMATION:

PLEASE SEE ATTACHED EXHIBITS

(c)(12): PHOTOGRAPHS:

PLEASE SEE ATTACHED EXHIBITS

(c)(13): DIGITAL MODULATION DESCRIPTION:

 ATTACHED EXHIBITS
 X N/A

(c)(14): TEST AND MEASUREMENT DATA:

FOLLOWS

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Sub-part

2.1033(c)(14):

TEST AND MEASUREMENT DATA

All tests and measurement data shown were performed in accordance with FCC Rules and Regulations, Volume II; Part 2, Sub-part J, Sections 2.947, 2.1033(c), 2.1041, 2.1046, 2.1047, 2.1079, 2.1051, 2.1053, 2.1055, 2.1057 and the following individual Parts:

- _____ 21 - Domestic Public Fixed Radio Services
- _____ 22 - Public Mobile Services
- _____ 22 Subpart H - Cellular Radiotelephone Service
- _____ 22.901(d) - Alternative technologies and auxiliary services
- _____ 23 - International Fixed Public Radiocommunication services
- _____ 24 - Personal Communications Services
- _____ 74 Subpart H - Low Power Auxiliary Stations
- _____ 80 - Stations in the Maritime Services
- _____ 80 Subpart E - General Technical Standards
- _____ 80 Subpart F - Equipment Authorization for Compulsory Ships
- _____ 80 Subpart K - Private Coast Stations and Marine Utility Stations
- _____ 80 Subpart S - Compulsory Radiotelephone Installations for Small Passenger Boats
- _____ 80 Subpart T - Radiotelephone Installation Required for Vessels on the Great Lakes
- _____ 80 Subpart U - Radiotelephone Installations Required by the Bridge-to-Bridge Act
- _____ 80 Subpart V - Emergency Position Indicating Radiobeacons (EPIRB'S)
- _____ 80 Subpart W - Global Maritime Distress and Safety System (GMDSS)
- _____ 80 Subpart X - Voluntary Radio Installations
- _____ 87 - Aviation Services
- x 90 - Private Land Mobile Radio Services
- _____ 94 - Private Operational-Fixed Microwave Service
- _____ 95 Subpart A - General Mobile Radio Service (GMRS)
- _____ 95 Subpart C - Radio Control (R/C) Radio Service
- _____ 95 Subpart D - Citizens Band (CB) Radio Service
- _____ 95 Subpart E - Family Radio Service
- _____ 95 Subpart F - Interactive Video and Data Service (IVDS)
- _____ 97 - Amateur Radio Service
- _____ 101 - Fixed Microwave Services

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STANDARD TEST CONDITIONS
and
ENGINEERING PRACTICES

Except as noted herein, the following conditions and procedures were observed during the testing:

In accordance with ANSI C63.4-1992/2000 Draft, section 6.1.9, and unless otherwise indicated in the specific measurement results, the ambient temperature of the actual EUT was maintained within the range of 10° to 40°C (50° to 104 °F) unless the particular equipment requirements specify testing over a different temperature range. Also, unless otherwise indicated, the humidity levels were in the range of 10% to 90% relative humidity.

Prior to testing, the EUT was tuned up in accordance with the manufacturer's alignment procedures. All external gain controls were maintained at the position of maximum and/or optimum gain throughout the testing.

Measurement results, unless otherwise noted, are worst case measurements.

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NAME OF TEST: Carrier Output Power (Conducted)
SPECIFICATION: 47 CFR 2.1046(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.1
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was connected to a resistive coaxial attenuator of normal load impedance, and the unmodulated output power was measured by means of an R. F. Power Meter.
2. Measurement accuracy is $\pm 3\%$.

MEASUREMENT RESULTS
(worst case)

FREQUENCY OF CARRIER, MHz = 498.6, 485.1, 511.9

POWER SETTING	R. F. POWER, WATTS
Low	10
High	40

SUPERVISED BY:

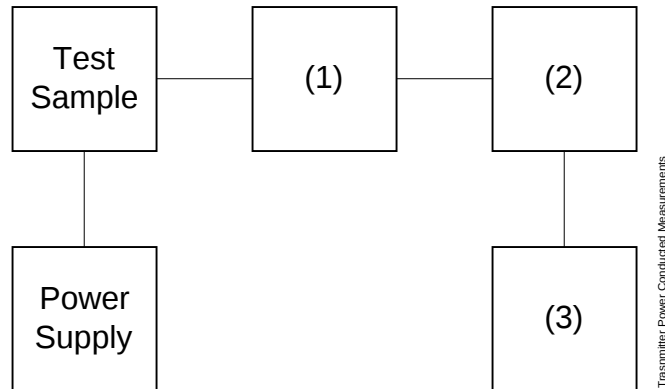

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TRANSMITTER POWER CONDUCTED MEASUREMENTS

TEST 1: R. F. POWER OUTPUT
 TEST 2: FREQUENCY STABILITY



Asset	Description (as applicable)	s/n
(1)	<u>COAXIAL ATTENUATOR</u>	
i00122	Narda 766-10	7802
i00123	Narda 766-10	7802A
i00069	Bird 8329 (30 dB)	1006
i00113	Sierra 661A-3D	1059
(2)	<u>POWER METERS</u>	
i00014	HP 435A	1733A05836
i00039	HP 436A	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(3)	<u>FREQUENCY COUNTER</u>	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A FREQUENCY MODE	2105A01087

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)

SPECIFICATION: 47 CFR 2.1051

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.13

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The emissions were measured for the worst case as follows:
 - (a): within a band of frequencies defined by the carrier frequency plus and minus one channel.
 - (b): from the lowest frequency generated in the EUT and to at least the 10th harmonic of the carrier frequency, or 40 GHz, whichever is lower.
2. The magnitude of spurious emissions that are attenuated more than 20 dB below the permissible value need not be specified.
3. MEASUREMENT RESULTS: ATTACHED FOR WORST CASE

FREQUENCY OF CARRIER, MHz = 498.6, 485.1, 511.9

SPECTRUM SEARCHED, GHz = 0 to 10 x F_c

MAXIMUM RESPONSE, Hz = 3160

ALL OTHER EMISSIONS = ≥ 20 dB BELOW LIMIT

LIMIT(S), dBc

-(50+10xLOG P) = -60 (10 Watts)

-(50+10xLOG P) = -66 (40 Watts)

SUPERVISED BY:

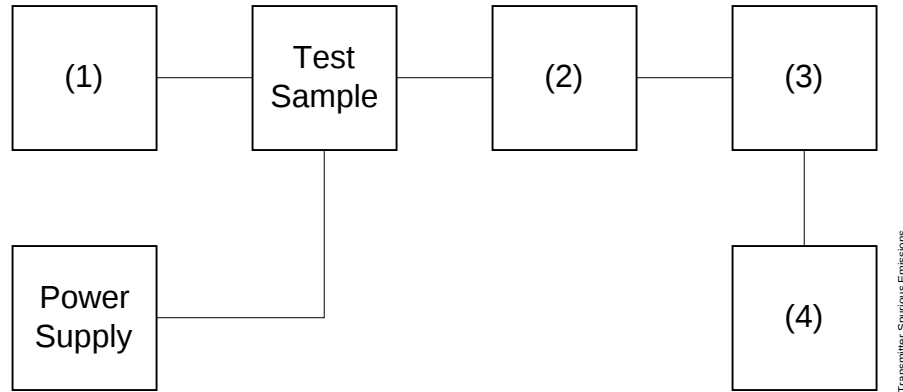

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TRANSMITTER SPURIOUS EMISSION

TEST A. OCCUPIED BANDWIDTH (IN-BAND SPURIOUS)
 TEST B. OUT-OF-BAND SPURIOUS



Asset Description (as applicable)	s/n
(1) <u>AUDIO OSCILLATOR/GENERATOR</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00012 HP 3312A	1432A11250
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 Narda 766-10	7802
i00123 Narda 766-10	7802A
i00069 Bird 8329 (30 dB)	1006
i00113 Sierra 661A-3D	1059
(3) <u>FILTERS; NOTCH, HP, LP, BP</u>	
i00126 Eagle TNF-1	100-250
i00125 Eagle TNF-1	50-60
i00124 Eagle TNF-1	250-850
(4) <u>SPECTRUM ANALYZER</u>	
i00048 HP 8566B	2511A01467
i00029 HP 8563E	3213A00104

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0090222: 2000-Sep-14 Thu 12:02:00
 STATE: 1:Low Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
485.100000	970.209000	-33.2	-73.2	-13.2
498.600000	997.209000	-35.3	-75.3	-15.3
511.900000	1023.800000	-34.8	-74.8	-14.8
485.100000	1455.296000	-42	-82	-22
498.600000	1495.797000	-41	-81	-21
511.900000	1535.693000	-38.9	-78.9	-18.9
485.100000	1940.687000	-40.7	-80.7	-20.7
498.600000	1994.111000	-40.1	-80.1	-20.1
511.900000	2047.334000	-41	-81	-21
485.100000	2425.773000	-40.1	-80.1	-20.1
498.600000	2493.005000	-39.3	-79.3	-19.3
511.900000	2559.503000	-42.1	-82.1	-22.1
485.100000	2910.139000	-43.1	-83.1	-23.1
498.600000	2991.863000	-42.2	-82.2	-22.2
511.900000	3071.556000	-43	-83	-23
485.100000	3396.072000	-42.4	-82.4	-22.4
498.600000	3490.653000	-43.4	-83.4	-23.4
511.900000	3583.048000	-43	-83	-23
485.100000	3880.649000	-43.6	-83.6	-23.6
498.600000	3988.903000	-43.7	-83.7	-23.7
511.900000	4095.030000	-43.1	-83.1	-23.1
485.100000	4365.758000	-42.9	-82.9	-22.9
498.600000	4487.143000	-42.1	-82.1	-22.1
511.900000	4607.441000	-42.5	-82.5	-22.5
485.100000	4850.686000	-43.2	-83.2	-23.2
498.600000	4986.165000	-43.1	-83.1	-23.1
511.900000	5118.849000	-43	-83	-23
485.100000	5336.038000	-42.6	-82.6	-22.6
498.600000	5484.654000	-42.7	-82.7	-22.7
511.900000	5630.799000	-42.6	-82.6	-22.6
485.100000	5820.828000	-38.1	-78.1	-18.1
498.600000	5983.643000	-37.3	-77.3	-17.3
511.900000	6142.354000	-38.3	-78.3	-18.3
485.100000	6305.967000	-36.8	-76.8	-16.8
498.600000	6481.830000	-36.6	-76.6	-16.6
511.900000	6654.295000	-37.4	-77.4	-17.4
485.100000	6791.561000	-37.7	-77.7	-17.7
498.600000	6980.070000	-37	-77	-17
511.900000	7166.393000	-36.7	-76.7	-16.7
485.100000	7276.123000	-37.8	-77.8	-17.8
498.600000	7479.242000	-37.9	-77.9	-17.9
511.900000	7678.128000	-37.3	-77.3	-17.3

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NAME OF TEST: Unwanted Emissions (Transmitter Conducted)
 g0090221: 2000-Sep-14 Thu 12:00:00
 STATE: 2:High Power

FREQUENCY TUNED, MHz	FREQUENCY EMISSION, MHz	LEVEL, dBm	LEVEL, dBc	MARGIN, dB
485.100000	970.223000	-30.6	-76.6	-10.6
498.600000	997.185000	-30.6	-76.6	-10.6
511.900000	1023.740000	-30.4	-76.4	-10.4
485.100000	1454.881000	-30.9	-76.9	-10.9
498.600000	1495.801000	-30.9	-76.9	-10.9
511.900000	1535.710000	-31.2	-77.2	-11.2
485.100000	1940.860000	-31.8	-77.8	-11.8
498.600000	1994.091000	-30.2	-76.2	-10.2
511.900000	2047.335000	-31.1	-77.1	-11.1
485.100000	2425.106000	-30	-76	-10
498.600000	2492.784000	-29.9	-75.9	-9.9
511.900000	2559.506000	-31.5	-77.5	-11.5
485.100000	2910.716000	-33.5	-79.5	-13.5
498.600000	2991.388000	-32.1	-78.1	-12.1
511.900000	3071.574000	-32.7	-78.7	-12.7
485.100000	3395.927000	-33.6	-79.6	-13.6
498.600000	3490.328000	-33.2	-79.2	-13.2
511.900000	3582.813000	-33.3	-79.3	-13.3
485.100000	3880.647000	-33.9	-79.9	-13.9
498.600000	3988.438000	-33.2	-79.2	-13.2
511.900000	4095.263000	-33	-79	-13
485.100000	4365.634000	-33.4	-79.4	-13.4
498.600000	4487.808000	-33.4	-79.4	-13.4
511.900000	4607.417000	-33.2	-79.2	-13.2
485.100000	4850.761000	-32.8	-78.8	-12.8
498.600000	4985.911000	-33.1	-79.1	-13.1
511.900000	5118.857000	-33.3	-79.3	-13.3
485.100000	5335.963000	-32.3	-78.3	-12.3
498.600000	5485.020000	-32.1	-78.1	-12.1
511.900000	5630.463000	-33.5	-79.5	-13.5
485.100000	5821.399000	-27.2	-73.2	-7.2
498.600000	5982.797000	-28.2	-74.2	-8.2
511.900000	6143.184000	-27	-73	-7
485.100000	6305.850000	-27.7	-73.7	-7.7
498.600000	6481.716000	-26.9	-72.9	-6.9
511.900000	6654.510000	-27.7	-73.7	-7.7
485.100000	6791.314000	-27.6	-73.6	-7.6
498.600000	6980.814000	-28.3	-74.3	-8.3
511.900000	7166.930000	-28.3	-74.3	-8.3
485.100000	7276.898000	-27.2	-73.2	-7.2
498.600000	7478.599000	-27.7	-73.7	-7.7
511.900000	7678.930000	-27.2	-73.2	-7.2

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NAME OF TEST: Field Strength of Spurious Radiation

SPECIFICATION: 47 CFR 2.1053(a)

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.12

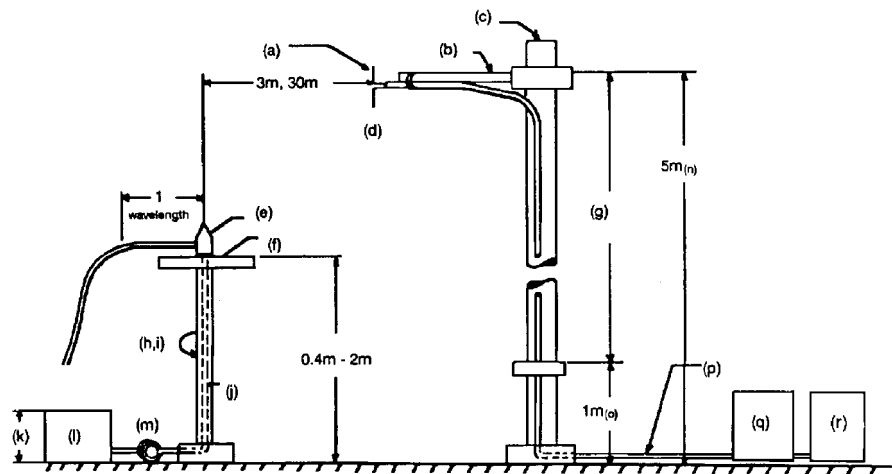
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. A description of the measurement facilities was filed with the FCC and was found to be in compliance with the requirements of Section 2.948, by letter from the FCC dated March 3, 1997, FILE 31040/SIT. All pertinent changes will be reported to the Commission by up-date prior to March 2003.
2. At first, in order to locate all spurious frequencies and approximate amplitudes, and to determine proper equipment functioning, the test sample was set up at a distance of three meters from the test instrument. Valid spurious signals were determined by switching the power on and off.
3. In the field, the test sample was placed on a wooden turntable above ground at three (or thirty) meters away from the search antenna. Excess power leads were coiled near the power supply.

The cables were oriented in order to obtain the maximum response. At each emission frequency, the turntable was rotated and the search antennas were raised and lowered vertically.
4. The emission was observed with both a vertically polarized and a horizontally polarized search antenna and the worst case was used.
6. The field strength of each emission within 20 dB of the limit was recorded and corrected with the appropriate cable and transducer factors.
7. The worst case for all channels is shown.
8. Measurement results: ATTACHED FOR WORST CASE

RADIATED TEST SETUP



NOTES:

- (a)Search Antenna - Rotatable on boom
- (b)Non-metallic boom
- (c)Non-metallic mast
- (d)Adjustable horizontally
- (e)Equipment Under Test
- (f)Turntable
- (g)Boom adjustable in height.
- (h)External control cables routed horizontally at least one wavelength.
- (i)Rotatable
- (j)Cables routed through hollow turntable center
- (k)30 cm or less
- (l)External power source
- (m)10 cm diameter coil of excess cable
- (n)25 cm (V), 1 m-7 m (V, H)
- (o)25 cm from bottom end of 'V', 1m normally
- (p)Calibrated Cable at least 10m in length
- (q)Amplifier (optional)
- (r)Spectrum Analyzer

Asset Description (as applicable)	s/n	Cycle	Last Cal
Per ANSI C63.4-1992/2000 Draft, 10.1.4			
TRANSDUCER			
i00088 EMC0 3109-B 25MHz-300MHz	2336	12 mo.	Sep-99
i00065 EMC0 3301-B Active Monopole	2635	12 mo.	Sep-99
i00089 Aprel 2001 200MHz-1GHz	001500	12 mo.	Sep-99
i00103 EMC0 3115 1GHz-18GHz	9208-3925	12 mo.	Sep-99
AMPLIFIER			
i00028 HP 8449A	2749A00121	12 mo.	Mar-00
SPECTRUM ANALYZER			
i00029 HP 8563E	3213A00104	12 mo.	Aug-00
i00033 HP 85462A	3625A00357	12 mo.	May-00
i00048 HP 8566B	2511AD1467	6 mo.	May-00

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NAME OF TEST: Field Strength of Spurious Radiation

ALL OTHER EMISSIONS = $\geq$ 20 dB BELOW LIMIT

<u>EMISSION, MHz/HARMONIC</u>	<u>SPURIOUS LEVEL, dBc</u>
2nd to 10th	<-70

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
SPECIFICATION: 47 CFR 2.1049(c)(1)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.11
TEST EQUIPMENT: As per previous page

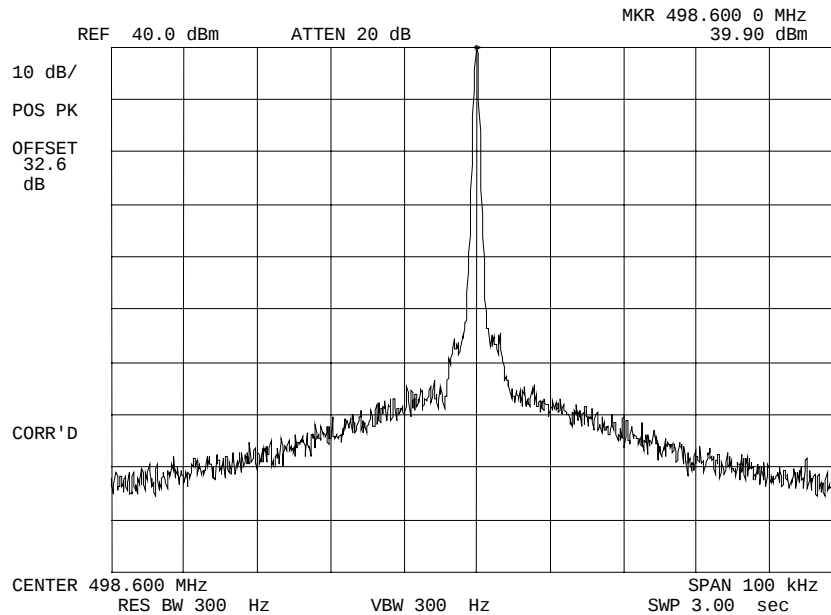
MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page, with the Spectrum Analyzer connected.
2. For EUTs supporting audio modulation, the audio signal generator was adjusted to the frequency of maximum response and with output level set for $\pm 2.5/\pm 1.25$ kHz deviation (or 50% modulation). With level constant, the signal level was increased 16 dB.
3. For EUTs supporting digital modulation, the digital modulation mode was operated to its maximum extent.
4. The Occupied Bandwidth was measured with the Spectrum Analyzer controls set as shown on the test results.
5. MEASUREMENT RESULTS: ATTACHED

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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090212: 2000-Sep-14 Thu 11:21:00
 STATE: 1:Low Power



POWER:
MODULATION:

LOW
NONE

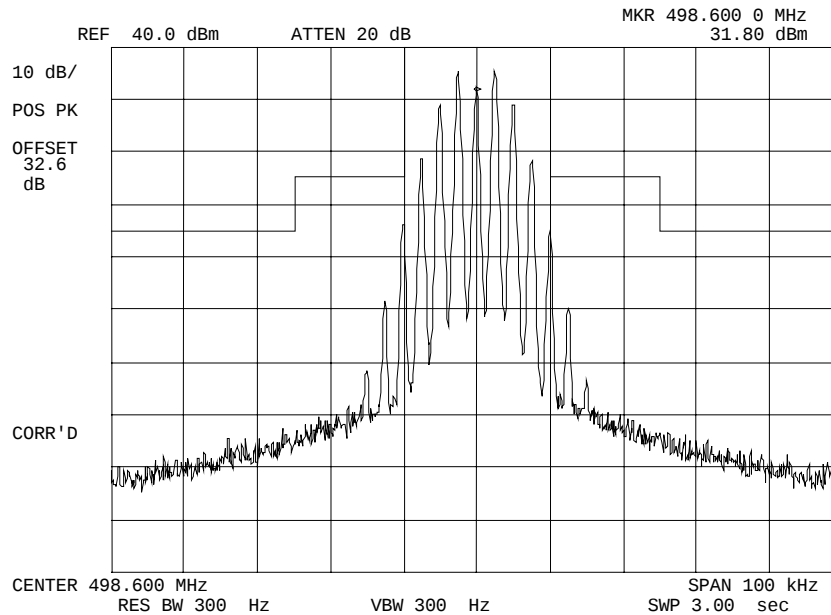
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090213: 2000-Sep-14 Thu 11:23:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 VOICE: 2500 HZ SINE WAVE
 MASK: B, VHF/UHF 25kHz,
 w/LPF

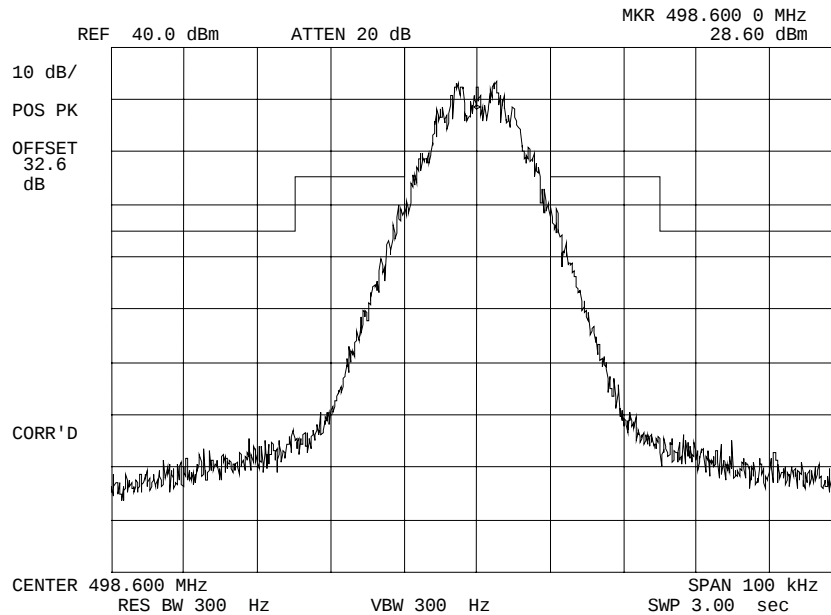
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090220: 2000-Sep-14 Thu 11:59:00
 STATE: 1:Low Power



POWER:
MODULATION:

LOW
DATA 19200 BITS PER SECOND
MASK: B, VHF/UHF 25kHz,
w/LPF

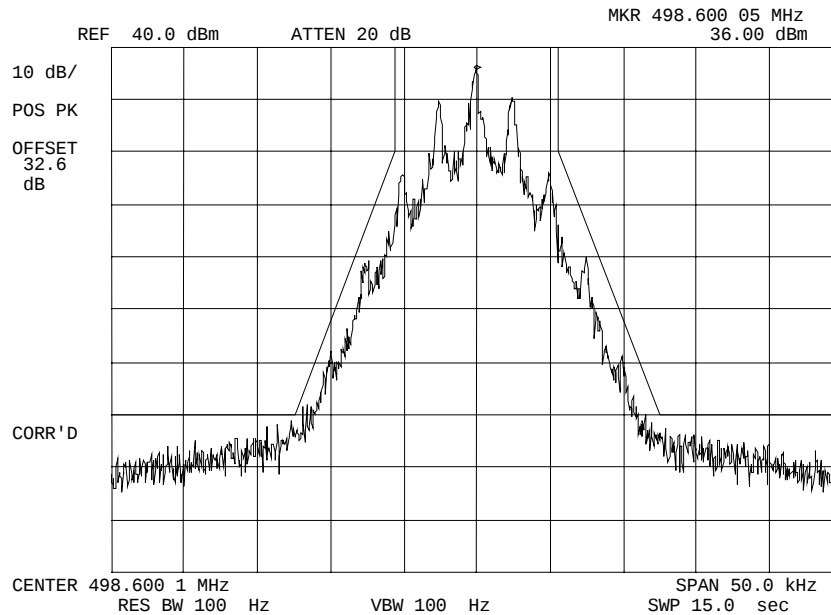
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090218: 2000-Sep-14 Thu 11:53:00
 STATE: 1:Low Power



POWER:
 MODULATION:

LOW
 DATA 9600 BITS PER SECOND
 MASK: D, VHF/UHF 12.5kHz BW

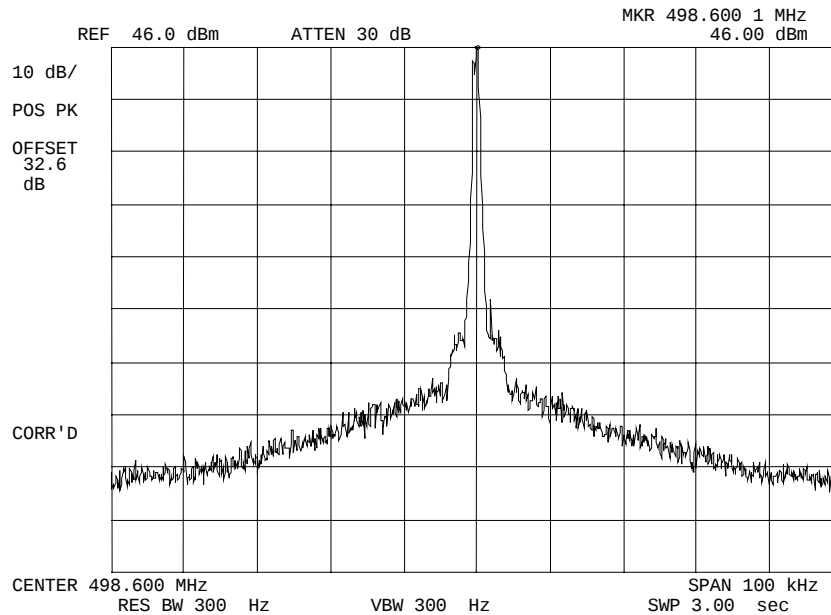
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090211: 2000-Sep-14 Thu 11:19:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
NONE

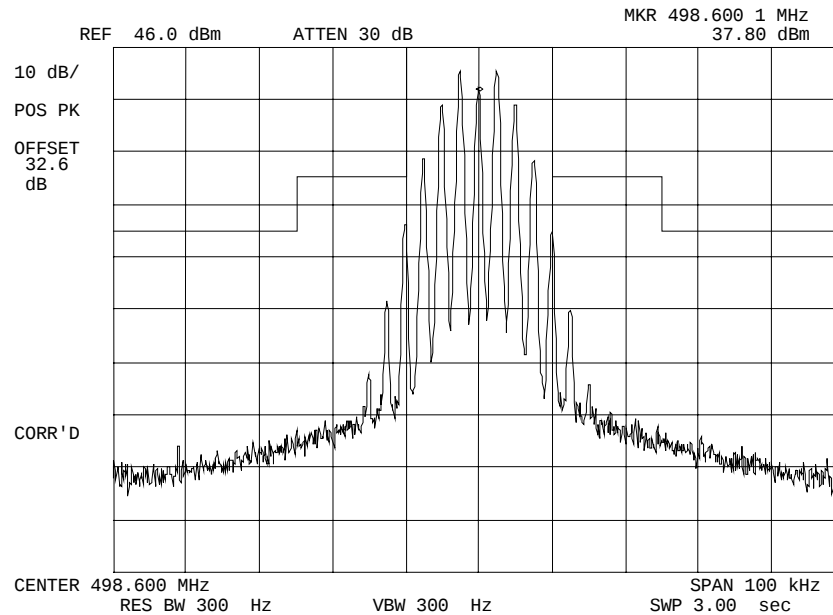
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090214: 2000-Sep-14 Thu 11:25:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 VOICE: 2500 HZ SINE WAVE
 MASK: B, VHF/UHF 25kHz,
 w/LPF

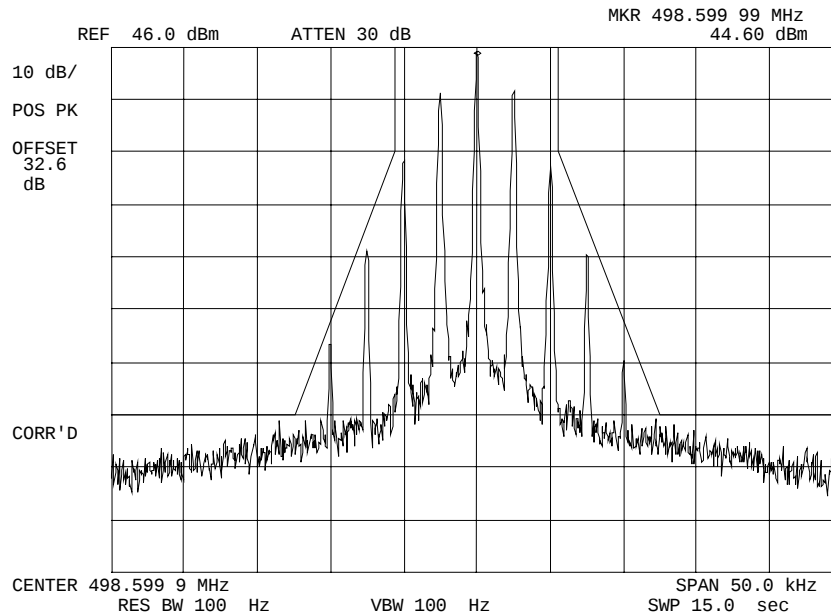
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090215: 2000-Sep-14 Thu 11:30:00
 STATE: 2:High Power



POWER:
 MODULATION:

HIGH
 VOICE: 2500 HZ SINE WAVE
 MASK: D, VHF/UHF 12.5kHz BW

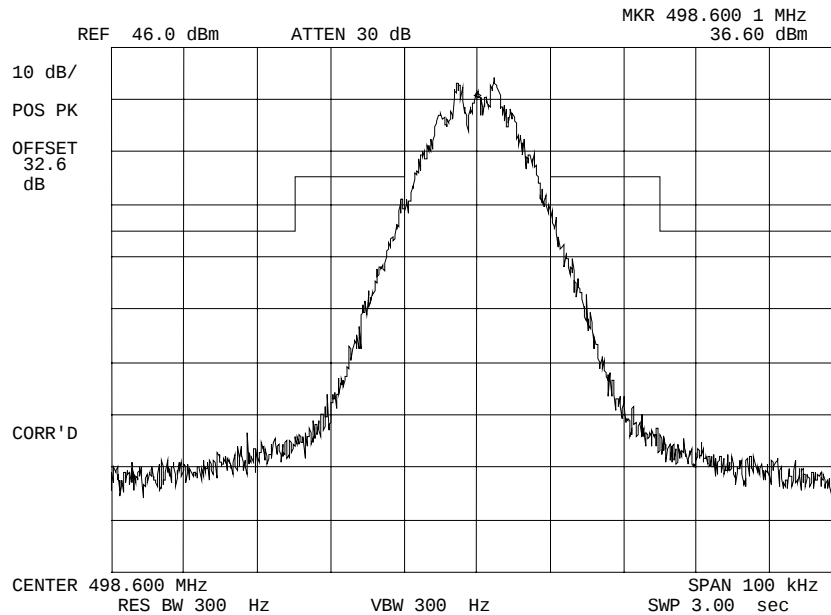
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090219: 2000-Sep-14 Thu 11:58:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
DATA 19200 BITS PER SECOND
MASK: B, VHF/UHF 25kHz,
w/LPF

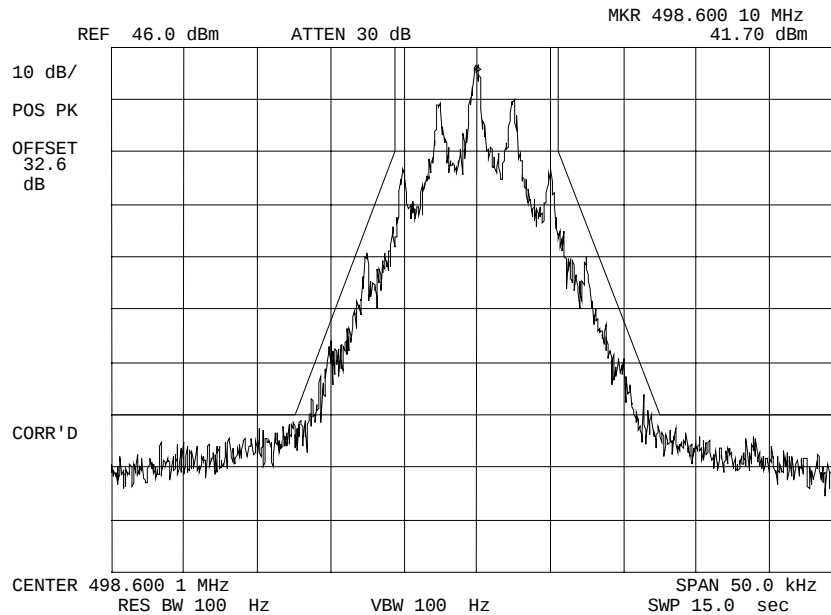
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NAME OF TEST: Emission Masks (Occupied Bandwidth)
 g0090217: 2000-Sep-14 Thu 11:51:00
 STATE: 2:High Power



POWER:
MODULATION:

HIGH
DATA 9600 BITS PER SECOND
MASK: D, VHF/UHF 12.5kHz BW

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NAME OF TEST: Transient Frequency Behavior

SPECIFICATION: 47 CFR 90.214

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.19

TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT was setup as shown on the attached page, following TIA/EIA-603 steps a, b, and c as a *guide*.
2. The transmitter was turned on.
3. Sufficient attenuation was provided so that the transmitter carrier level measured at the output of the combiner was 40 dB below the maximum input level of the test receiver. This level was recorded as step f.
4. The transmitter was turned off.
5. An RF signal generator (1) modulated with a 1 kHz tone at either 25, 12.5, or 6.25 kHz deviation, and set to the same frequency as the assigned transmitter frequency, (2) was adjusted to a level -20 dB below the level recorded for step f, as measured at the output of the combiner. This level was then fixed for the remainder of the test and is recorded at step h.
6. The oscilloscope was setup using TIA/EIA-603 steps j and k as a guide, and to either 10 ms/div (UHF) or 5 ms/div (VHF).
7. The 30 dB attenuator was removed, the transmitter was turned on, and the level of the carrier at the output of the combiner was recorded as step l.
8. The carrier on-time as referenced in TIA/EIA-603 steps m, n, and o was captured and plotted. The carrier off-time as referenced in TIA/EIA-603 steps p, q, r, and s was captured and plotted.

LEVELS MEASURED:

<u>step f</u> , dBm	= -14.6
<u>step h</u> , dBm	= -46.3
<u>step l</u> , dBm	= 3.7

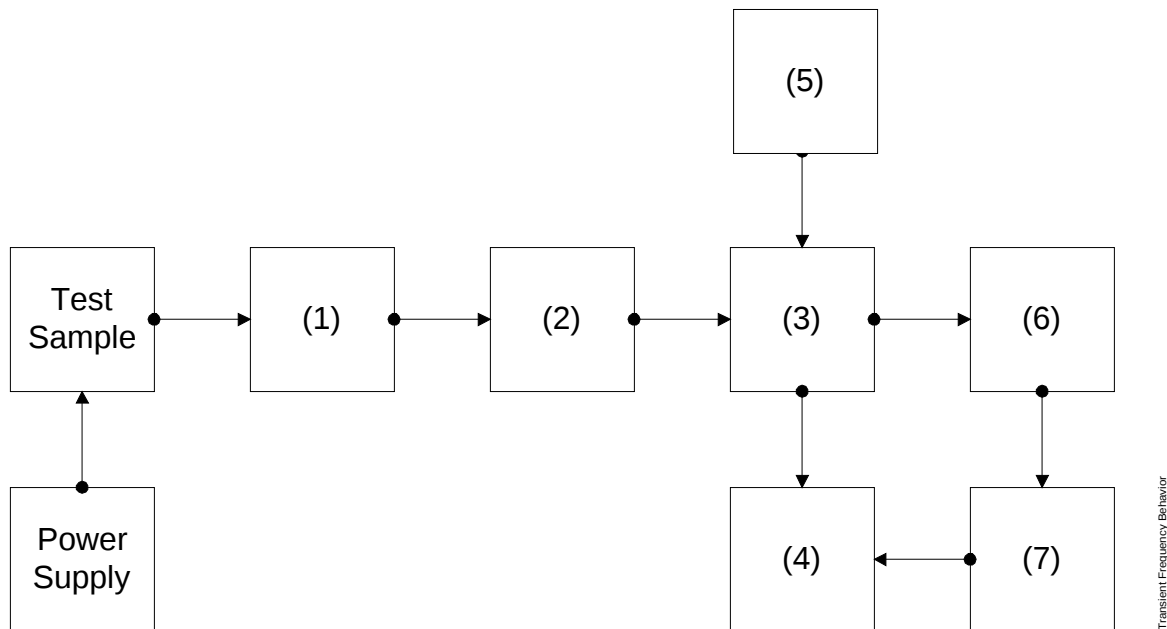


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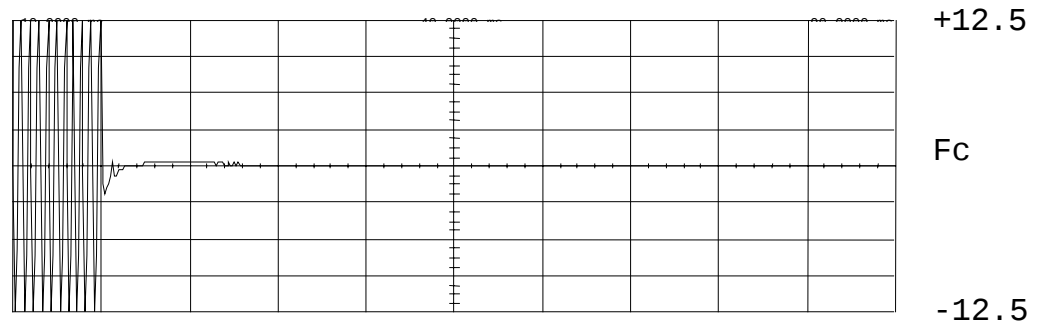
TRANSIENT FREQUENCY BEHAVIOR

Asset	Description (as applicable)	s/n
(1)	ATTENUATOR (Removed after 1st step)	
	i00112 Philco 30 dB	989
(2)	ATTENUATOR	
	i00112 Philco 30 dB	989
	i00172 Bird 30 dB	989
	i00122 Narda 10 dB	7802
	i00123 Narda 10 dB	7802A
	i00110 Kay Variable	145-387
(3)	COMBINER	
	i00154 4 x 25 Ω COMBINER	154
(4)	CRYSTAL DETECTOR	
	i00159 HP 8470B	1822A10054
(5)	RF SIGNAL GENERATOR	
	i00018 HP 8656A	2228A03472
	i00031 HP 8656A	2402A06180
	i00067 HP 8920A	3345U01242
(6)	MODULATION ANALYZER	
	i00020 HP 8901A	2105A01087
(7)	SCOPE	
	i00030 HP 54502A	2927A00209

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NAME OF TEST: Transient Frequency Behavior
 g0090227: 2000-Sep-14 Thu 16:25:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Pos 10.0000 ms Reference Center Mode
 Main 10.0 ms/div 10.0000 ms Center Position
 Channel 1 Sensitivity 275 mV/div Offset 0.00000 V Scale 1.000 1 d (1M ohm)
 Trigger mode Edge On Rising Edge of chan2
 Trigger Level 4.500 mV (noise gate + 0V)
 Holdoff 10.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER ON TIME

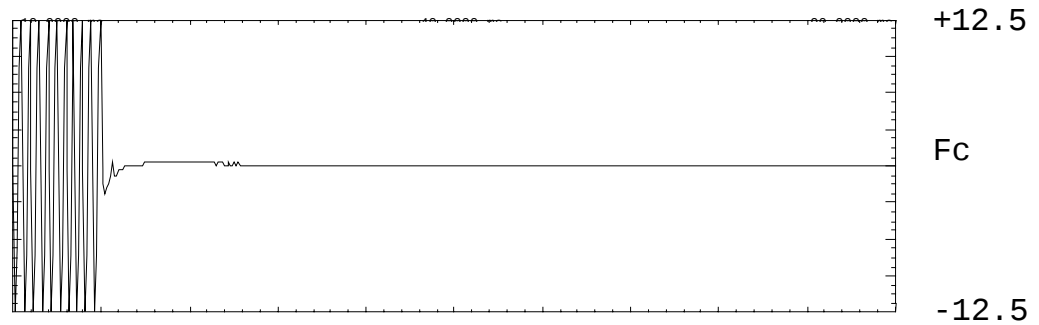
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NAME OF TEST: Transient Frequency Behavior
 g0090228: 2000-Sep-14 Thu 16:25:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Pos 10.0000 ms Defocus 0 Mode
 Main 10.0 ms/div 10.0000 ms center Repetition
 Channel 1 Sensitivity 275 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Rising Edge of chan2
 Trigger level 4.500 mV (noise gate 0.0V)
 Holdoff 10.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER ON TIME

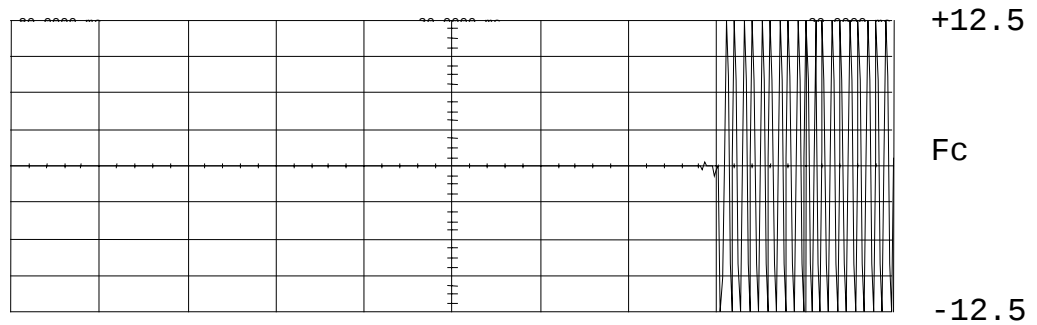
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NAME OF TEST: Transient Frequency Behavior
 g0090229: 2000-Sep-14 Thu 16:27:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Proc 00.0000 ms Reference Center Mode Repetitive
 Channel 1 Sensitivity 275 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Position Edge of keep Trigger Level keep 240.750 mV (noise gate + 0V) Holdoff 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER OFF TIME

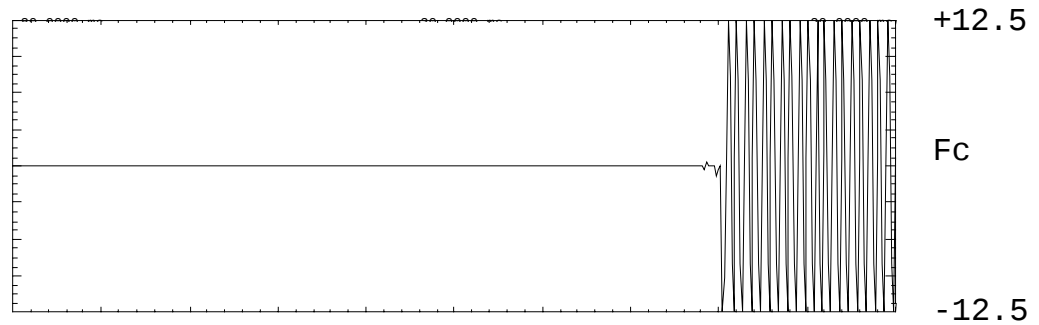
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NAME OF TEST: Transient Frequency Behavior
 g0090230: 2000-Sep-14 Thu 16:27:00
 STATE: 2:High Power



Main Timebase 10.0 ms/div Delay/Proc 00.0000 ms Defeas 0 Mode
 channel 1 Sensitivity 275 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge
 On Position Edge of h003
 Trigger Level
 h003 240.750 mV (noise gate + 0V)
 Holdoff 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER OFF TIME

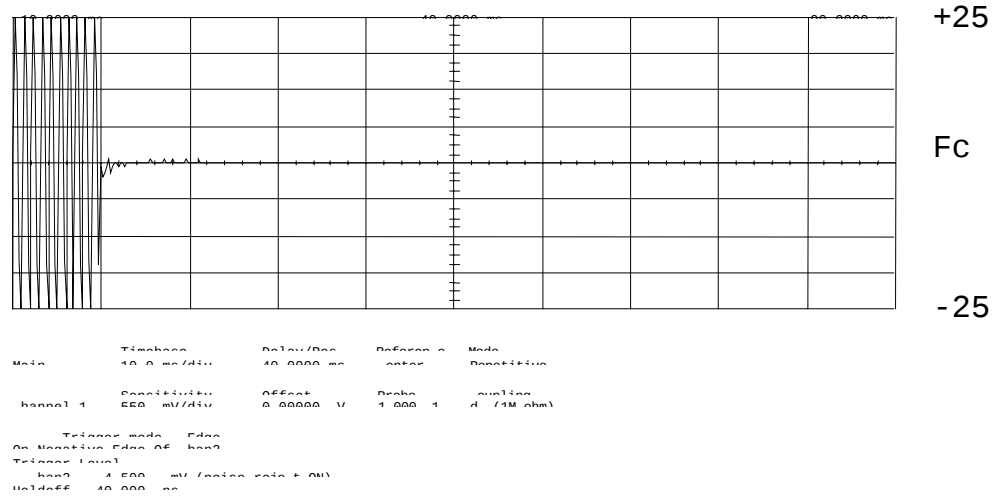
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NAME OF TEST: Transient Frequency Behavior
 g0090223: 2000-Sep-14 Thu 16:20:00
 STATE: 2:High Power



POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER ON TIME

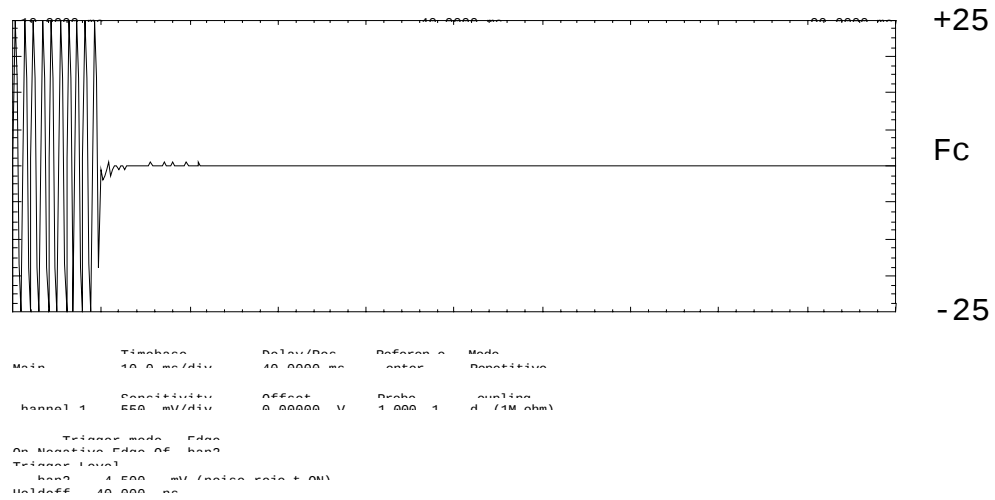
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NAME OF TEST: Transient Frequency Behavior
 g0090224: 2000-Sep-14 Thu 16:20:00
 STATE: 2:High Power



POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER ON TIME

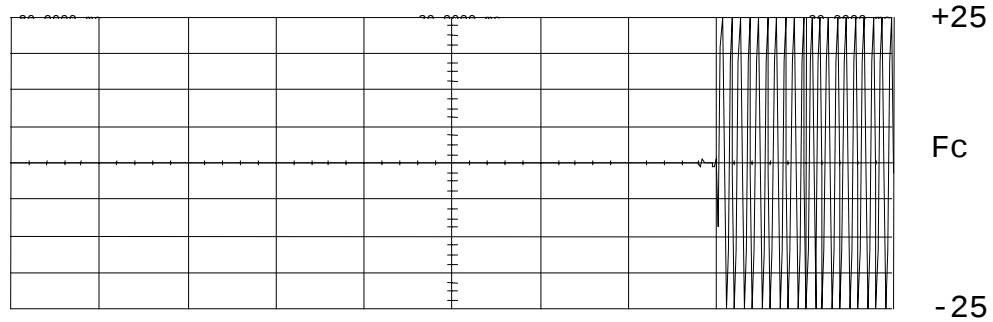
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NAME OF TEST: Transient Frequency Behavior
 g0090225: 2000-Sep-14 Thu 16:22:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Proc 00.0000 ms Reference Center Mode Repetitive
 Channel 1 Sensitivity 500 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Positive Edge of chan2
 Trigger Level chan2 007.500 mV (noise gate 0.0V)
 Holdoff 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER OFF TIME

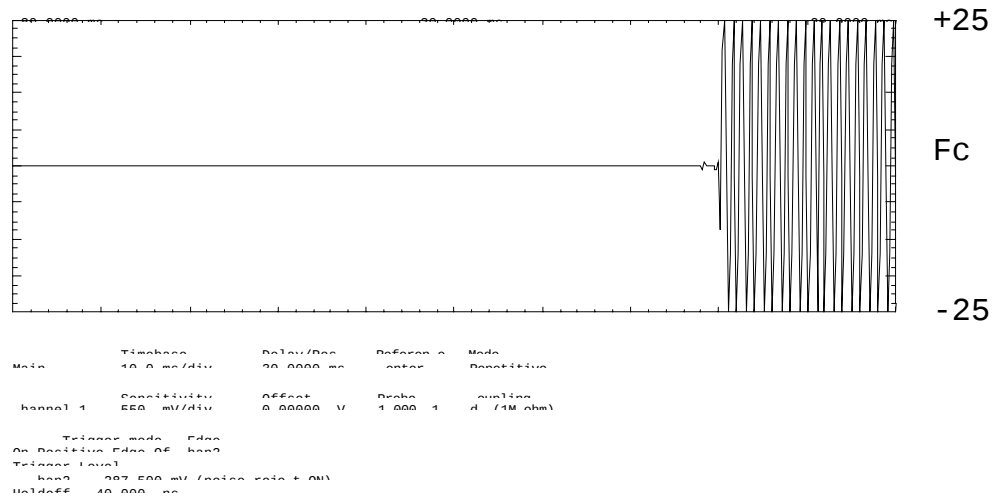
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NAME OF TEST: Transient Frequency Behavior
 g0090226: 2000-Sep-14 Thu 16:22:00
 STATE: 2:High Power



POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER OFF TIME

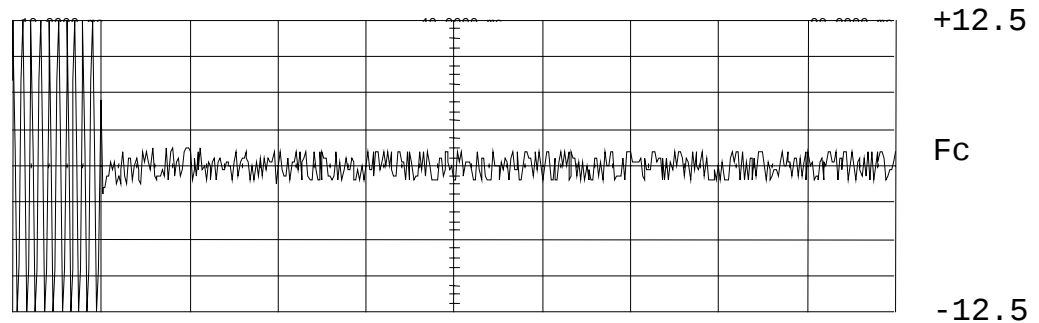
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NAME OF TEST: Transient Frequency Behavior
 g0090231: 2000-Sep-14 Thu 16:29:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Proc 10.0000 ms Reference Center Mode
 Main 10.0 ms/div 10.0000 ms Center Repetitive
 Channel 1 275 mV/div Offset 0.00000 V Scale 1.000 1 d (1M ohm)
 Trigger mode Edge On Rising Edge of chan2
 Trigger Level 4.500 mV (noise gate + 0V)
 Holdoff 10.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER ON TIME

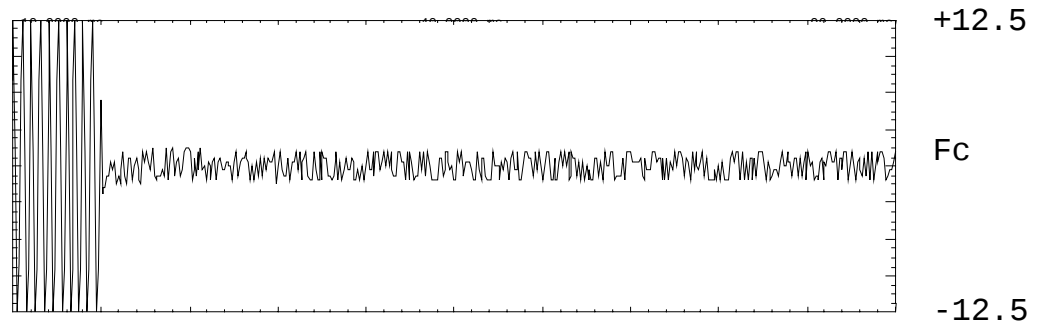
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NAME OF TEST: Transient Frequency Behavior
 g0090232: 2000-Sep-14 Thu 16:30:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Pos 10.0000 ms Reference Center Mode
 Main 10.0 ms/div 10.0000 ms Center Positive
 Channel 1 275 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Rising Edge of chan2
 Trigger Level 4.500 mV (noise gate + 0V)
 Holdoff 10.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER ON TIME

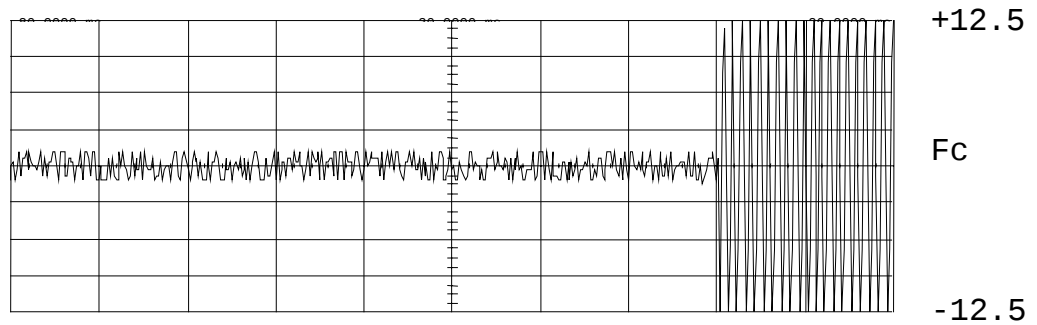
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NAME OF TEST: Transient Frequency Behavior
 g0090233: 2000-Sep-14 Thu 16:31:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Proc 00.0000 sec Reference Center Mode
 Main 10.0 ms/div Delay/Proc 00.0000 sec Reference Center Mode
 Channel 1 Sensitivity 275 mV/div Offset 0.00000 V Scale 1.000 1 d (1M ohm)
 Trigger mode Edge
 As Position Edge of h003
 Trigger Level h003 240.750 mV (noise gate + 0V)
 Holdoff 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

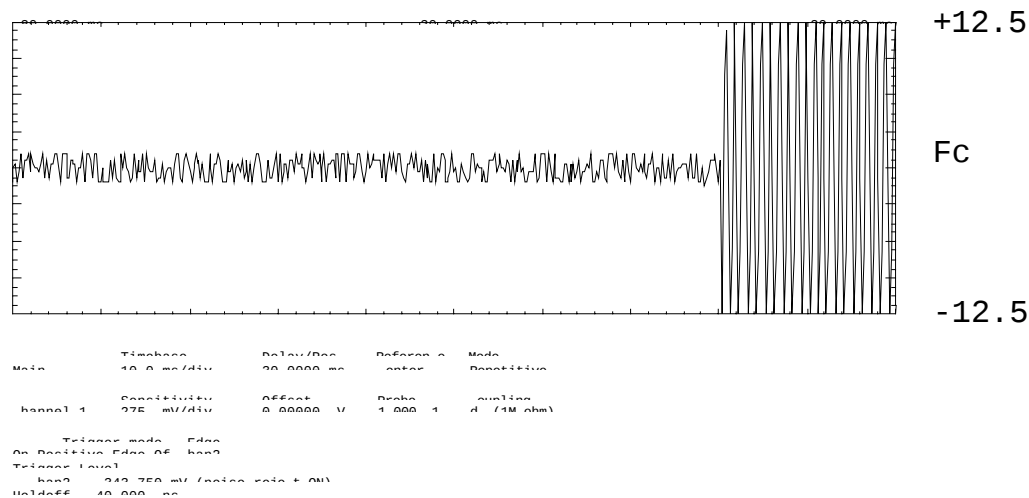
HIGH
 Ref Gen=12.5 kHz Deviation
 CARRIER OFF TIME

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NAME OF TEST: Transient Frequency Behavior
g0090234: 2000-Sep-14 Thu 16:31:00
STATE: 2:High Power



POWER:	HIGH
MODULATION:	Ref Gen=12.5 kHz Deviation
DESCRIPTION:	CARRIER OFF TIME

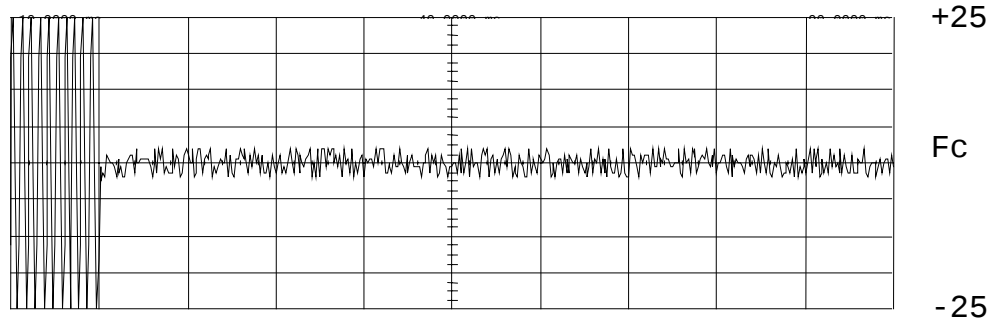
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NAME OF TEST: Transient Frequency Behavior
 g0090235: 2000-Sep-14 Thu 16:36:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Proc 10.0000 ms Reference Center Mode
 Main 10.0 ms/div 10.0000 ms Center Repetitive
 Channel 1 Sensitivity 500 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Transition Edge of chan2
 Trigger Level chan2 4.500 mV (noise gate + 0V)
 Holdoff 10.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER ON TIME

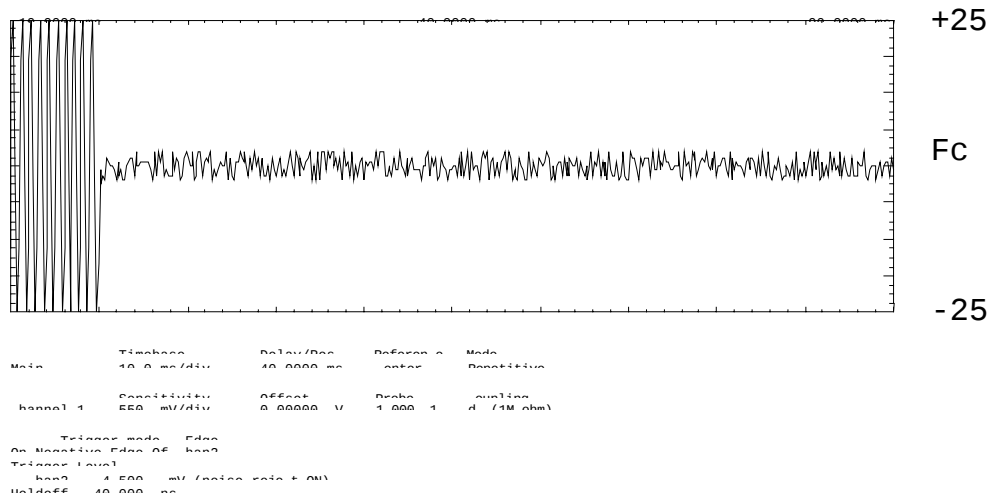
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NAME OF TEST: Transient Frequency Behavior
 g0090236: 2000-Sep-14 Thu 16:36:00
 STATE: 2:High Power



POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER ON TIME

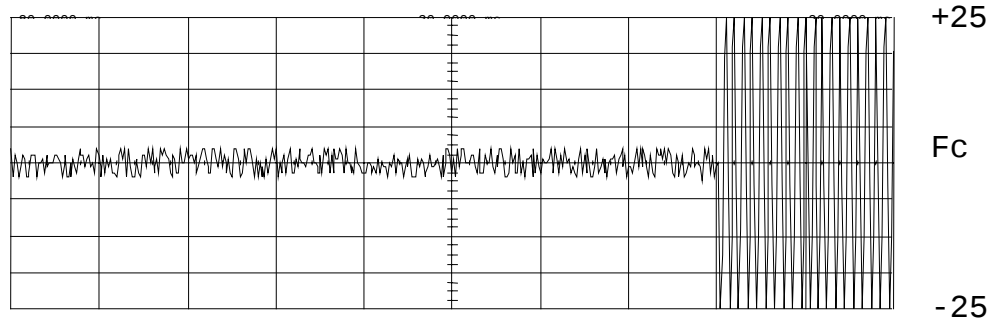
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NAME OF TEST: Transient Frequency Behavior
 g0090237: 2000-Sep-14 Thu 16:38:00
 STATE: 2:High Power



Timebase 10.0 ms/div Delay/Pos 00.0000 ms Reference Center Mode Repetitive
 Channel 1 Sensitivity 500 mV/div Offset 0.00000 V Scale 1.000 1 d (1M ohm)
 Trigger mode Edge On Position Edge of keep Trigger Level keep 240.750 mV (noise gate + 0V) Holdoff 40.000 ms

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER OFF TIME

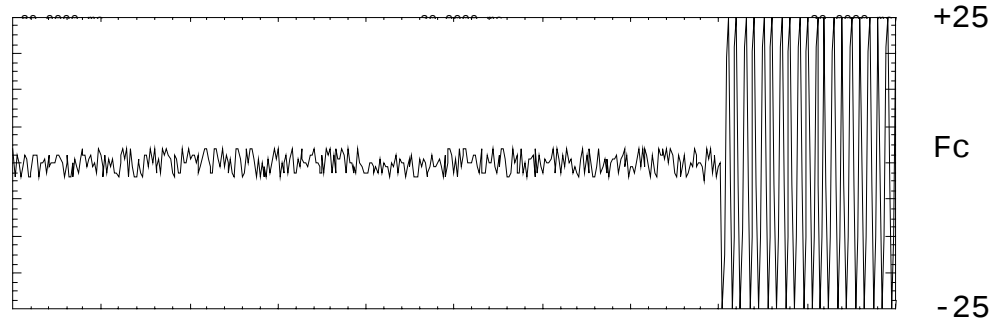
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NAME OF TEST: Transient Frequency Behavior
 g0090238: 2000-Sep-14 Thu 16:38:00
 STATE: 2:High Power



Main Timebase 10.0 ms/div Delay/Proc 00.0000 ms Reference Center Mode Repetitive
 Channel 1 Sensitivity 500 mV/div Offset 0.00000 V Probe 1.000 1 d (1M ohm)
 Trigger mode Edge On Positive Edge of chan2
 Trigger Level chan2 240.750 mV (noise gate + 0V)
 Holdoff 40.000 ns

POWER:
 MODULATION:
 DESCRIPTION:

HIGH
 Ref Gen=25 kHz Deviation
 CARRIER OFF TIME

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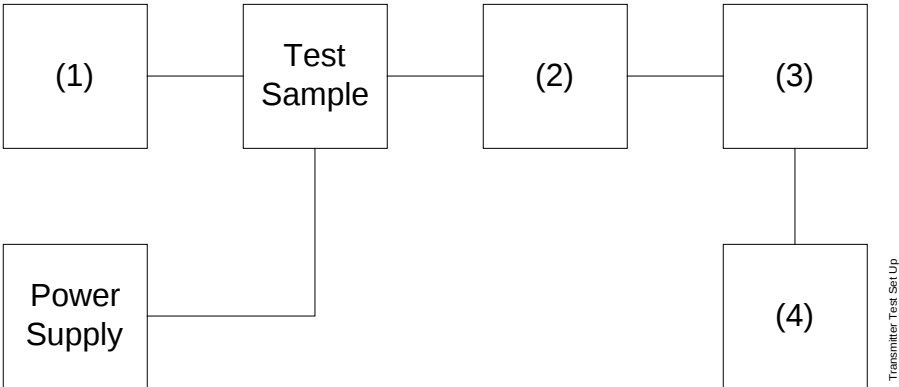
PAGE NO. 45 of 57.
NAME OF TEST: Audio Low Pass Filter (Voice Input)
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.15
TEST EQUIPMENT: As per attached page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up such that the audio input was connected at the input to the modulation limiter, and the modulated stage.
2. The audio output was connected at the output to the modulated stage.
3. MEASUREMENT RESULTS: ATTACHED

TRANSMITTER TEST SET-UP

- TEST A. MODULATION CAPABILITY/DISTORTION
- TEST B. AUDIO FREQUENCY RESPONSE
- TEST C. HUM AND NOISE LEVEL
- TEST D. RESPONSE OF LOW PASS FILTER
- TEST E. MODULATION LIMITING

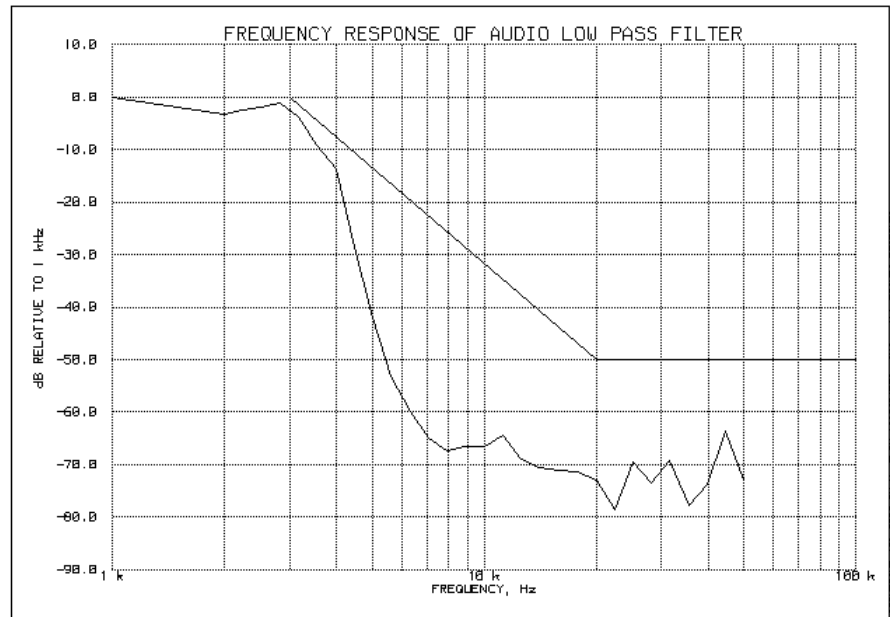


Asset Description (as applicable)	s/n
(1) <u>Audio Oscillator</u>	
i00010 HP 204D	1105A04683
i00017 HP 8903A	2216A01753
i00118 HP 33120A	US36002064
(2) <u>COAXIAL ATTENUATOR</u>	
i00122 NARDA 766-10	7802
i00123 NARDA 766-10	7802A
i00113 SIERRA 661A-3D	1059
i00069 BIRD 8329 (30 dB)	10066
(3) <u>MODULATION ANALYZER</u>	
i00020 HP 8901A	2105A01087
(4) <u>AUDIO ANALYZER</u>	
i00017 HP 8903A	2216A01753

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NAME OF TEST: Audio Low Pass Filter (Voice Input)
g0090191: 2000-Sep-14 Thu 10:30:00
STATE: 0:General



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NAME OF TEST: Audio Frequency Response
SPECIFICATION: 47 CFR 2.1047(a)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.6
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT and test equipment were set up as shown on the following page.
2. The audio signal generator was connected to the audio input circuit/microphone of the EUT.
3. The audio signal input was adjusted to obtain 20% modulation at 1 kHz, and this point was taken as the 0 dB reference level.
4. With input levels held constant and below limiting at all frequencies, the audio signal generator was varied from 100 Hz to 50 kHz.
5. The response in dB relative to 1 kHz was then measured, using the HP 8901A Modulation Analyzer.
6. MEASUREMENT RESULTS: ATTACHED

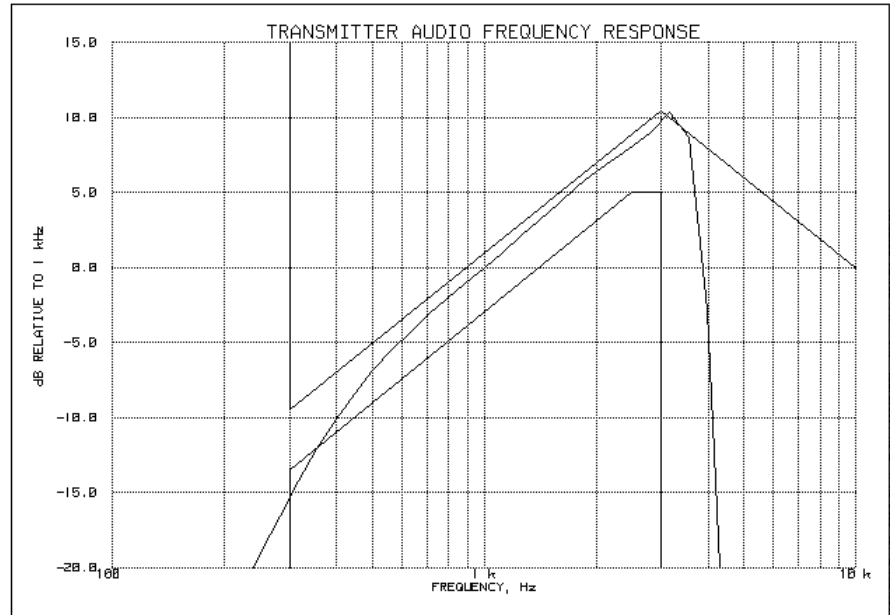
PAGE NO.

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NAME OF TEST: Audio Frequency Response

g0090190: 2000-Sep-14 Thu 10:27:00

STATE: 0:General



Frequency of Maximum Audio Response, Hz = 3160

Additional points:

FREQUENCY, Hz	LEVEL, dB
300	-15.31
20000	-31.79
30000	-31.24
50000	-32.14

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NAME OF TEST: Modulation Limiting
SPECIFICATION: 47 CFR 2.1047(b)
GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.3
TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

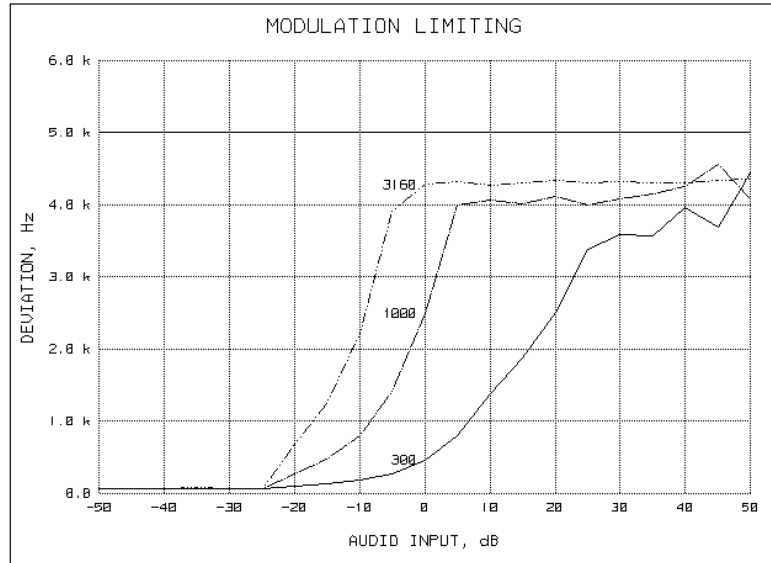
1. The signal generator was connected to the input of the EUT as for "Frequency Response of the Modulating Circuit."
2. The modulation response was measured for each of three frequencies (one of which was the frequency of maximum response), and the input voltage was varied and was observed on an HP 8901A Modulation Analyzer.
3. The input level was varied from 30% modulation (± 1.5 kHz deviation) to at least 20 dB higher than the saturation point.
4. Measurements were performed for both negative and positive modulation and the respective results were recorded.
5. MEASUREMENT RESULTS: ATTACHED

PAGE NO.

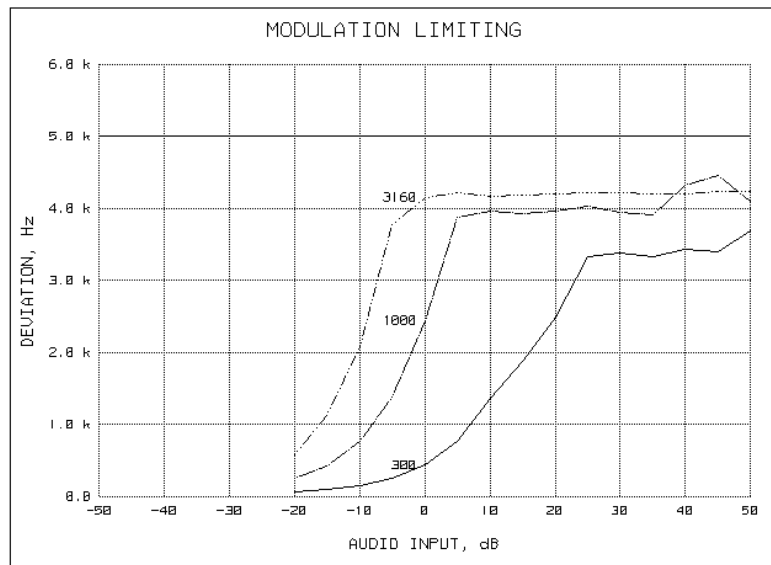
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NAME OF TEST: Modulation Limiting
 g0090197: 2000-Sep-14 Thu 10:38:00
 STATE: 0:General

Positive
 Peaks:



Negative
 Peaks:



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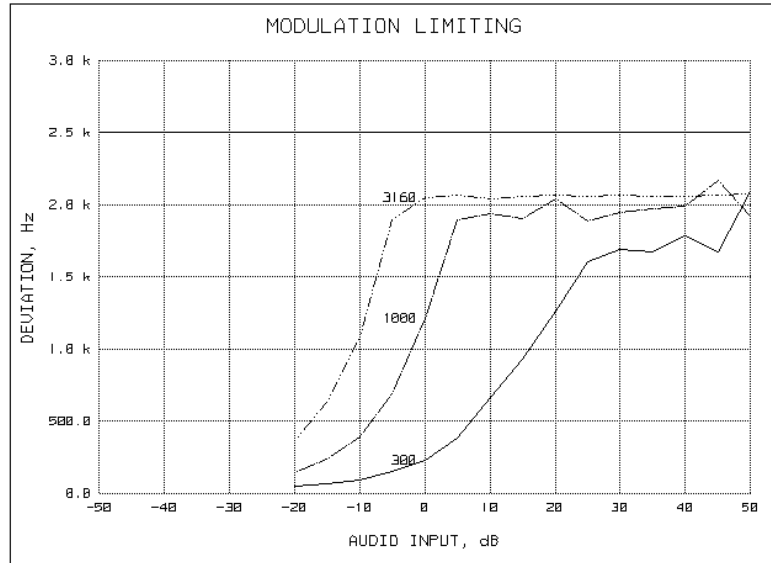
M. Flom P. Eng.
 Morton Flom, P. Eng.

PAGE NO.

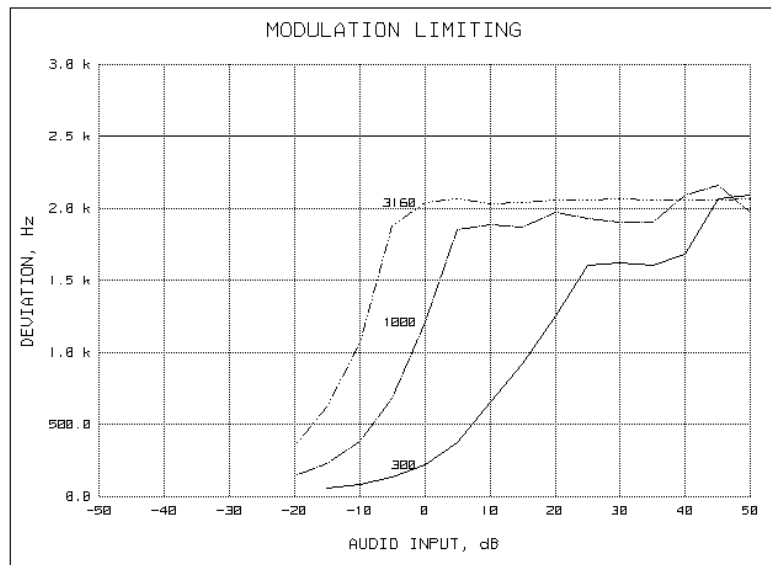
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NAME OF TEST: Modulation Limiting
 g0090199: 2000-Sep-14 Thu 10:46:00
 STATE: 0:General

Positive
 Peaks:



Negative
 Peaks:



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NAME OF TEST: Frequency Stability (Temperature Variation)

SPECIFICATION: 47 CFR 2.1055(a)(1)

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2

TEST CONDITIONS: As Indicated

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

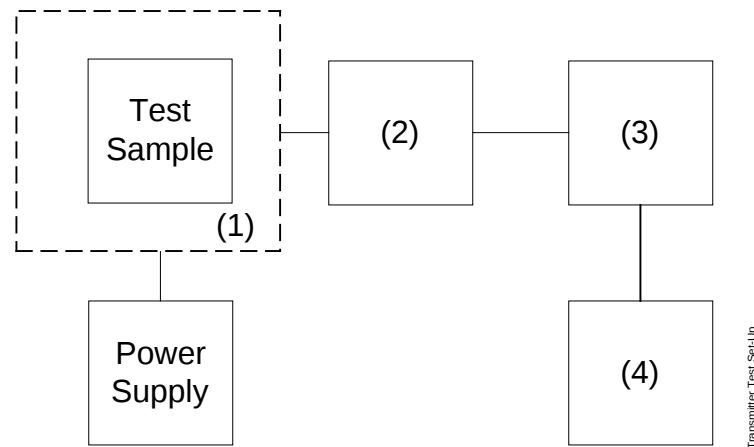
1. The EUT and test equipment were set up as shown on the following page.
2. With all power removed, the temperature was decreased to -30°C and permitted to stabilize for three hours. Power was applied and the maximum change in frequency was noted within one minute.
3. With power OFF, the temperature was raised in 10°C steps. The sample was permitted to stabilize at each step for at least one-half hour. Power was applied and the maximum frequency change was noted within one minute.
4. The temperature tests were performed for the worst case.
5. MEASUREMENT RESULTS: ATTACHED

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TRANSMITTER TEST SET-UP

TEST A. OPERATIONAL STABILITY
 TEST B. CARRIER FREQUENCY STABILITY
 TEST C. OPERATIONAL PERFORMANCE STABILITY
 TEST D. HUMIDITY
 TEST E. VIBRATION
 TEST F. ENVIRONMENTAL TEMPERATURE
 TEST G. FREQUENCY STABILITY: TEMPERATURE VARIATION
 TEST H. FREQUENCY STABILITY: VOLTAGE VARIATION

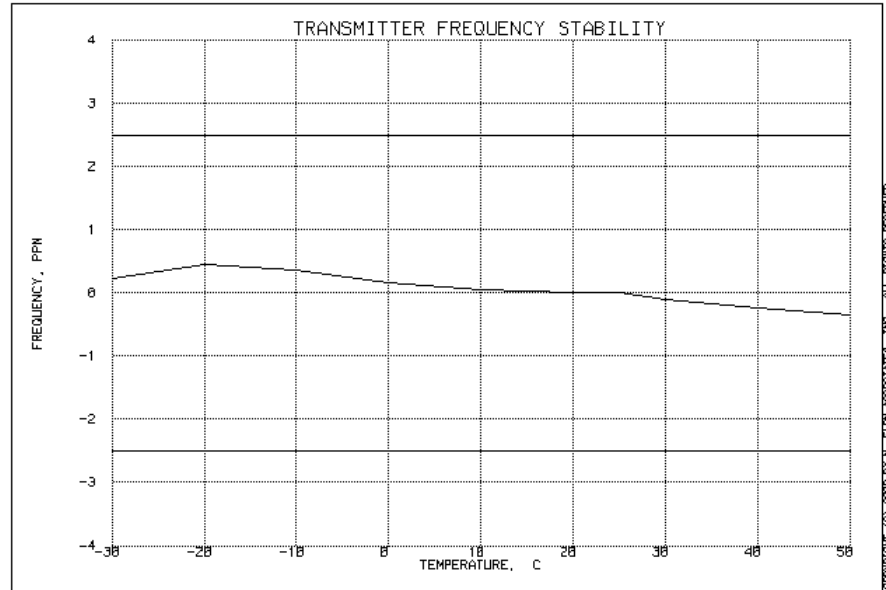


Asset	Description (as applicable)	s/n
(1)	<u>TEMPERATURE, HUMIDITY, VIBRATION</u>	
i00027	Tenny Temp. Chamber	9083-765-234
i00	Weber Humidity Chamber	
i00	L.A.B. RVH 18-100	
(2)	<u>COAXIAL ATTENUATOR</u>	
i00122	NARDA 766-10	7802
i00123	NARDA 766-10	7802A
i00113	SIERRA 661A-3D	1059
i00069	BIRD 8329 (30 dB)	10066
(3)	<u>R.F. POWER</u>	
i00014	HP 435A POWER METER	1733A05839
i00039	HP 436A POWER METER	2709A26776
i00020	HP 8901A POWER MODE	2105A01087
(4)	<u>FREQUENCY COUNTER</u>	
i00042	HP 5383A	1628A00959
i00019	HP 5334B	2704A00347
i00020	HP 8901A	2105A01087

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NAME OF TEST: Frequency Stability (Temperature Variation)
g0090207: 2000-Sep-14 Thu 16:47:00
STATE: 0:General



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NAME OF TEST: Frequency Stability (Voltage Variation)

SPECIFICATION: 47 CFR 2.1055(b)(1)

GUIDE: ANSI/TIA/EIA-603-1992, Paragraph 2.2.2

TEST EQUIPMENT: As per previous page

MEASUREMENT PROCEDURE

1. The EUT was placed in a temperature chamber at $25\pm 5^{\circ}\text{C}$ and connected as for "Frequency Stability - Temperature Variation" test.
2. The power supply voltage to the EUT was varied from 85% to 115% of the nominal value measured at the input to the EUT.
3. The variation in frequency was measured for the worst case.

RESULTS: Frequency Stability (Voltage Variation)

g0090210: 2000-Sep-14 Thu 11:11:27

STATE: 0:General

LIMIT, ppm = 2.5
 LIMIT, Hz = 1247
 BATTERY END POINT (Voltage) = 10

% of STV	Voltage	Frequency, MHz	Change, Hz	Change, ppm
85	11.56	498.600010	10	0.02
100	13.6	498.600000	0	0.00
115	15.64	498.600030	30	0.06
74	10	498.600610	610	1.22

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NAME OF TEST: Necessary Bandwidth and Emission Bandwidth

SPECIFICATION: 47 CFR 2.202(g)

MODULATION = 16K0F3E

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz	= 3
MAXIMUM DEVIATION (D), kHz	= 5
CONSTANT FACTOR (K)	= 1
NECESSARY BANDWIDTH (B _N), kHz	= (2xM)+(2xDxK)
	= 16.0

MODULATION = 11K0F3E

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz	= 3
MAXIMUM DEVIATION (D), kHz	= 2.5
CONSTANT FACTOR (K)	= 1
NECESSARY BANDWIDTH (B _N), kHz	= (2xM)+(2xDxK)
	= 11.0

MODULATION = 19K2F1D

NECESSARY BANDWIDTH CALCULATION:

MAXIMUM MODULATION (M), kHz	= 3
MAXIMUM DEVIATION (D), kHz	= 5
CONSTANT FACTOR (K)	= 1.3
NECESSARY BANDWIDTH (B _N), kHz	= (2xM)+(2xDxK)
	= 19.2

SUPERVISED BY:

Morton Flom, P. Eng.

TESTIMONIAL
AND
STATEMENT OF CERTIFICATION

THIS IS TO CERTIFY THAT:

1. THAT the application was prepared either by, or under the direct supervision of, the undersigned.
2. THAT the technical data supplied with the application was taken under my direction and supervision.
3. THAT the data was obtained on representative units, randomly selected.
4. THAT, to the best of my knowledge and belief, the facts set forth in the application and accompanying technical data are true and correct.

CERTIFYING ENGINEER:


Morton Flom, P. Eng.